

## FS541-VB Datasheet N-Channel 60 V (D-S) MOSFET

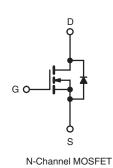
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	60				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	0.027			
Q <sub>g</sub> (Max.) (nC)	95				
Q <sub>gs</sub> (nC)	27				
Q <sub>gd</sub> (nC)	46				
Configuration	Single				

#### **FEATURES**

- · Isolated Package
- High Voltage Isolation = 2.5 kV<sub>RMS</sub> (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

# GDS

**TO-220 FULLPAK** 



ABSOLUTE MAXIMUM RATINGS T	<sub>C</sub> = 25 °C, u	nless otherw	vise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	60	V	
Gate-Source Voltage			V <sub>GS</sub>	± 20	v	
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_C = 25 \degree C$ $T_C = 100 \degree C$	- I <sub>D</sub>	45		
		$T_C = 100 ^{\circ}C$		30	А	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	220		
Linear Derating Factor				0.32	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	100	mJ	
Maximum Power Dissipation	T <sub>C</sub> =	25 °C	PD	52	W	
Peak Diode Recovery dV/dtc			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 <sup>d</sup>	C	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 129 µH,  $R_G = 25 \Omega$ ,  $I_{AS} = 30 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 52 \text{ A}$ ,  $dI/dt \le 250 \text{ A/µs}$ ,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175 \text{ °C}$ .

d. 1.6 mm from case.

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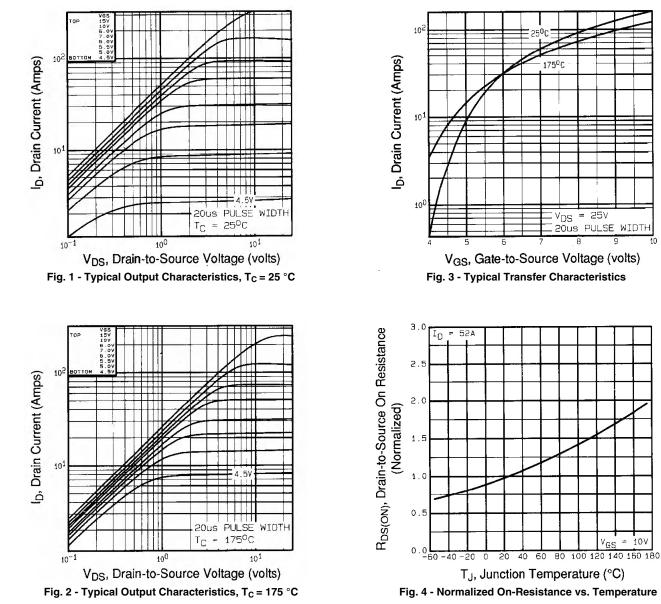
THERMAL RESISTANCE RAT	TINGS								
PARAMETER	SYMBOL	TYP	•	MAX.		UNIT			
Maximum Junction-to-Ambient	R <sub>thJA</sub>	- 65				°C ///			
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 3.1				°C/W			
<b>SPECIFICATIONS</b> $T_J = 25 \ ^{\circ}C$ ,	unless otherv	vise noted			1	T	T		
PARAMETER	SYMBOL	TES		IONS	MIN.	TYP.	MAX.	UNIT	
Static							1	-	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 $\mu$ A			-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	$I_D = 1 \text{ mA}$	-	0.060	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS},\ I_{D}=250\ \mu A$			1.0	-	3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{GS} = \pm 20 \text{ V}$			-	-	± 100	nA	
Zero Gate Voltage Drain Current		V <sub>DS</sub> =	= 60 V, V <sub>GS</sub>	= 0 V	-	-	25		
Zero Gale Voltage Drain Guirent	I <sub>DSS</sub>	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 150 ^{\circ}\text{C}$		T <sub>J</sub> = 150 °C	-	-	250	μA	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub>	= 18 A <sup>b</sup>	-	0.027	-	Ω	
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	= 25 V, I <sub>D</sub> =	18 A <sup>b</sup>	15	-	-	S	
Dynamic						-			
Input Capacitance	Ciss	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1.0  MHz,  see fig. 5 f = 1.0  MHz			-	1500	-		
Output Capacitance	C <sub>oss</sub>			-	720	-	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>			-	100	-			
Drain to Sink Capacitance	С			-	12	-			
Total Gate Charge	Qg				-	-	95	nC	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V		$I_D = 52 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and $13^{\text{b}}$	-	-	27		
Gate-Drain Charge	Q <sub>gd</sub>		566 II		-	-	46		
Turn-On Delay Time	t <sub>d(on)</sub>				-	19	-		
Rise Time	t <sub>r</sub>	$\label{eq:V_DD} \begin{array}{l} {\sf V}_{\rm DD} = 30 \; {\sf V}, \; {\sf I}_{\rm D} = 52 \; {\sf A}, \\ {\sf R}_{\rm G} = 9.1 \; \Omega, \; {\sf R}_{\rm D} = 0.54 \; \Omega, \\ {\sf see \; fig. \; 10^{\rm b}} \end{array}$		-	120	-	ns		
Turn-Off Delay Time	t <sub>d(off)</sub>			-	55	-			
Fall Time	t <sub>f</sub>			-	86	-			
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	Ls			-	7.5	-			
Drain-Source Body Diode Characteristic	s				•	•			
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the		-	-	45	A		
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode			-	-		120	
Body Diode Voltage	$V_{SD}$	$T_J = 25 \text{ °C}, I_S = 30 \text{ A}, V_{GS} = 0 \text{ V}^{b}$			-	-	2.5	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = 52 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	140	300	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	1.2	2.8	μC		
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	rn-on time	is negligible (turn	-on is dor	ninated by	y L <sub>S</sub> and L	_D)	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.

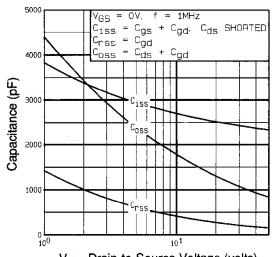


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#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





V<sub>DS</sub>, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

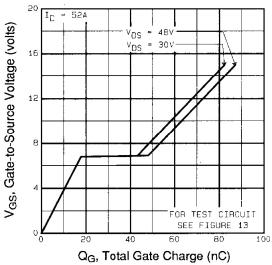


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

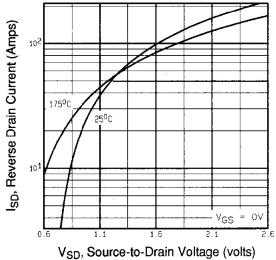
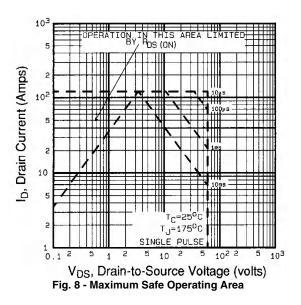


Fig. 7 - Typical Source-Drain Diode Forward Voltage



### FS541-VB



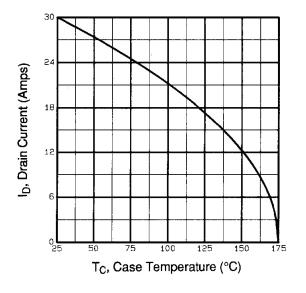


Fig. 9 - Maximum Drain Current vs. Case Temperature

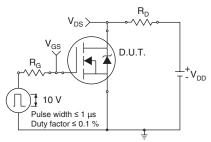


Fig. 10a - Switching Time Test Circuit

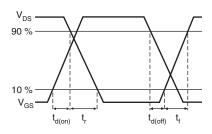


Fig. 10b - Switching Time Waveforms

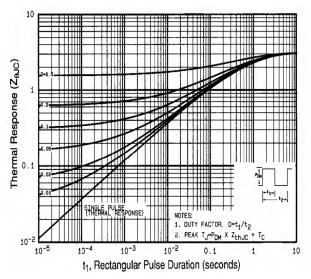
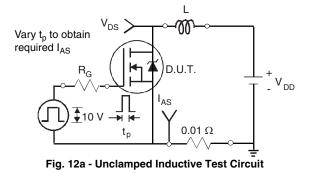


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



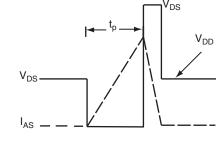
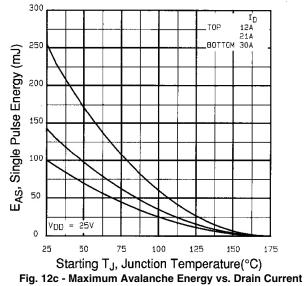


Fig. 12b - Unclamped Inductive Waveforms







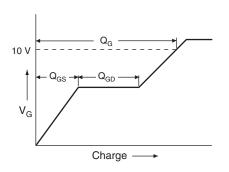
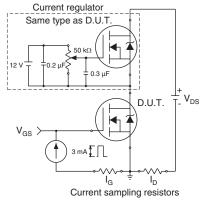
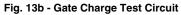
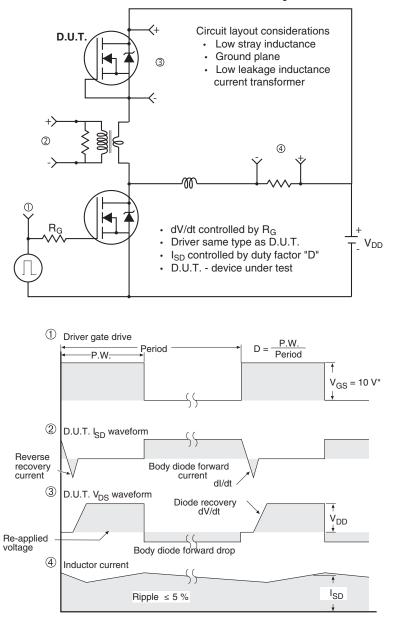


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

\*  $V_{GS} = 5$  V for logic level devices

Fig. 14 - For N-Channel



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